

## P-Channel 100-V (D-S) MOSFET

### PRODUCT SUMMARY

$V_{DS}$ (V)	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A) <sup>a</sup>	$Q_g$ (Typ.)
- 100	0.026 at $V_{GS} = - 10$ V	- 48	15 nC
	0.029 at $V_{GS} = - 4.5$ V		

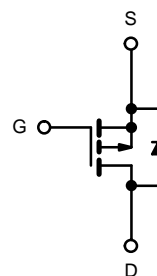
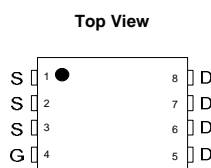
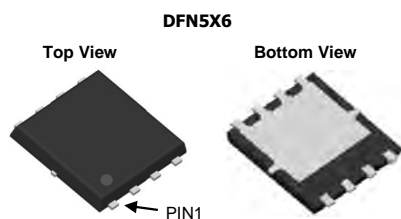
### FEATURES

- DT-Trench Power MOSFET
- 100 %  $R_g$  and UIS Tested


**RoHS**  
COMPLIANT

### APPLICATIONS

- Notebook
- Load Switch



P-Channel MOSFET

### ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	- 100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current ( $T_J = 150$ °C)	$I_D$	$T_C = 25$ °C	A
		$T_C = 70$ °C	
		$T_A = 25$ °C	
		$T_A = 70$ °C	
Pulsed Drain Current	$I_{DM}$	- 192	A
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25$ °C	
		$T_A = 25$ °C	mJ
Single Pulse Avalanche Current	$I_{AS}$	-48	
Single Pulse Avalanche Energy	$E_{AS}$	56	W
Maximum Power Dissipation	$P_D$	$T_C = 25$ °C	
		$T_C = 70$ °C	
		$T_A = 25$ °C	
		$T_A = 70$ °C	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		260	

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, f</sup>	$R_{thJA}$	19	40	°C/W
Maximum Junction-to-Case (Drain)	$R_{thJC}$	1.0	2.0	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c.  $t = 10$  s.

d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed

copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 54 °C/W.

**SPECIFICATIONS**  $T_J = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted

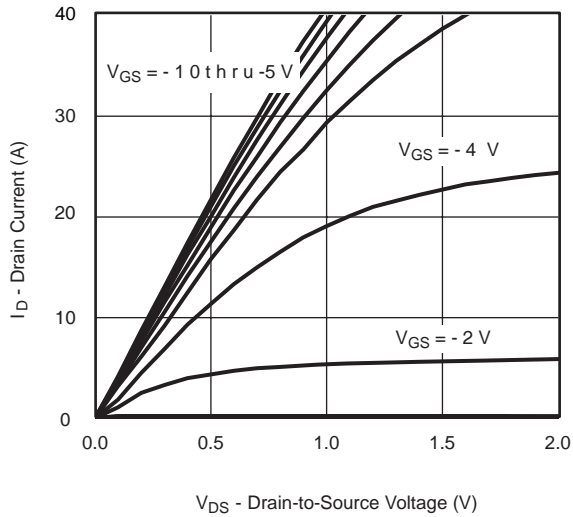
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 100			V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = - 250 μA		- 31		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	ΔV <sub>GS(th)</sub> /T <sub>J</sub>			6.5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 1.0		- 3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V			- 1	μA
		V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 10 V	- 48			A
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 15 A		0.026	0.035	Ω
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		0.029	0.040	
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 15 A		52		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V, f = 1 MHz		6950		pF
Output Capacitance	C <sub>oss</sub>			775		
Reverse Transfer Capacitance	C <sub>rss</sub>			215		
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 15 A		15		nC
		V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		12		
Q <sub>gs</sub>			20			
Q <sub>gd</sub>			32			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.1		Ω
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DS</sub> = - 80 V, R <sub>L</sub> = 15 Ω I <sub>D</sub> ≅ - 10 A, V <sub>GS</sub> = - 10 V, R <sub>g</sub> = 1 Ω		15		ns
Rise Time	t <sub>r</sub>			32		
Turn-Off Delay Time	t <sub>d(off)</sub>			27		
Fall Time	t <sub>f</sub>			20		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DS</sub> = - 80 V, R <sub>L</sub> = 15 Ω I <sub>D</sub> ≅ - 10 A, V <sub>GS</sub> = - 4.5 V, R <sub>g</sub> = 1 Ω		19		
Rise Time	t <sub>r</sub>			45		
Turn-Off Delay Time	t <sub>d(off)</sub>			35		
Fall Time	t <sub>f</sub>			23		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 48	A
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 192	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 10 A		- 0.7	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 10 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C		30		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			35		nC
Reverse Recovery Fall Time	t <sub>a</sub>			16		ns
Reverse Recovery Rise Time	t <sub>b</sub>			14		

Notes:

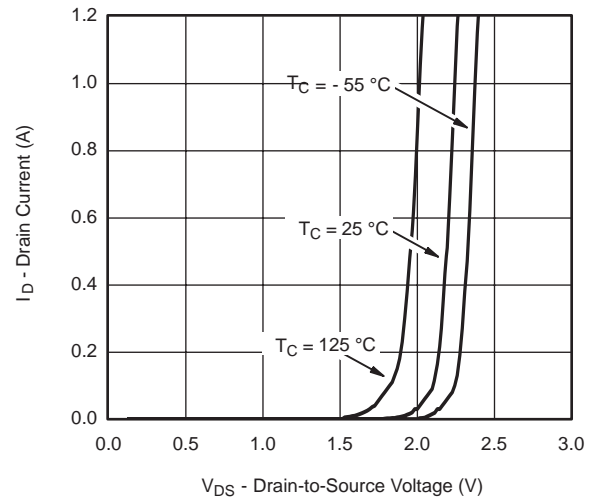
- a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .  
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

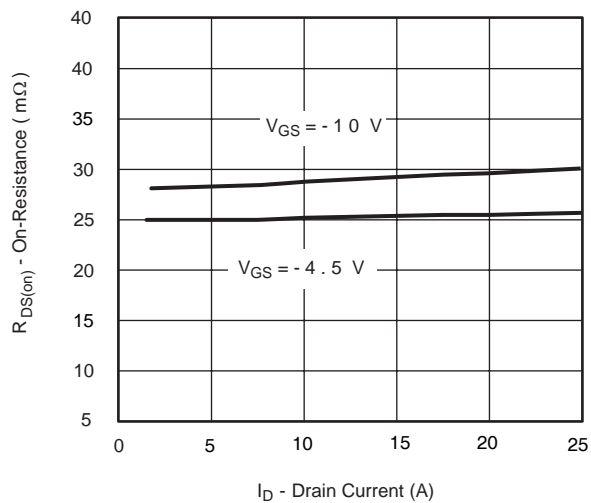
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



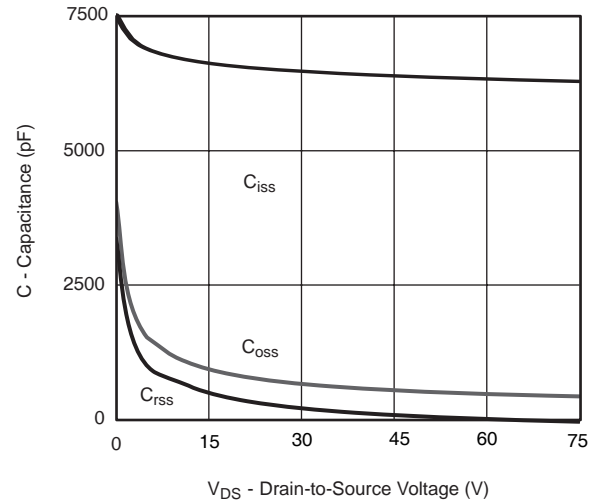
**Output Characteristics**



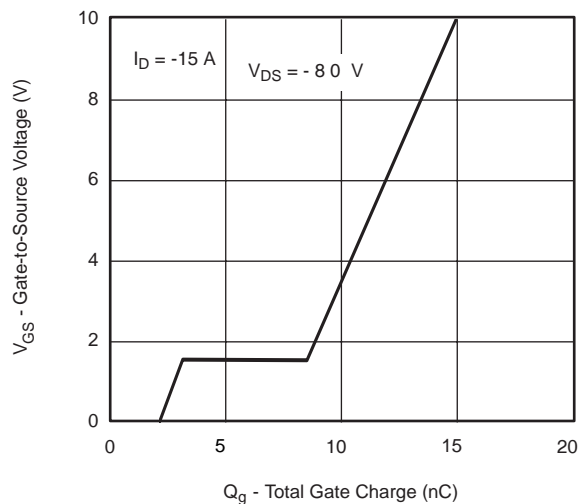
**Transfer Characteristics**



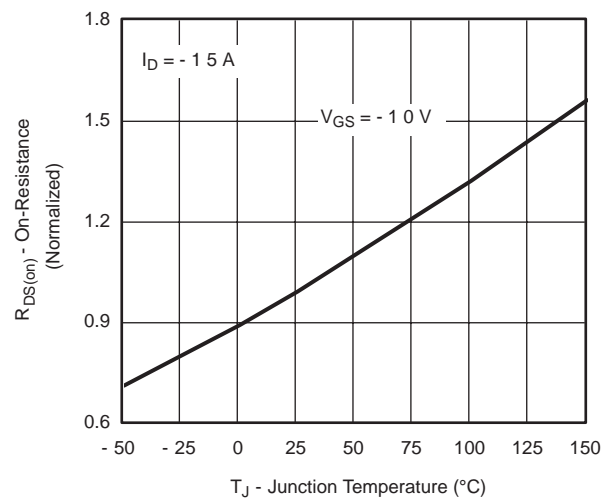
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

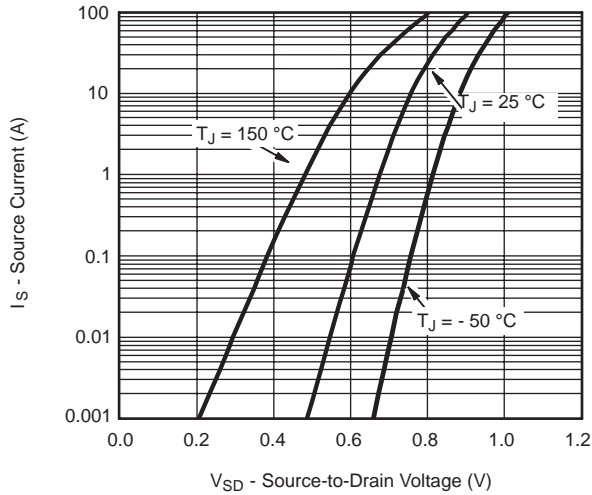


**Gate Charge**

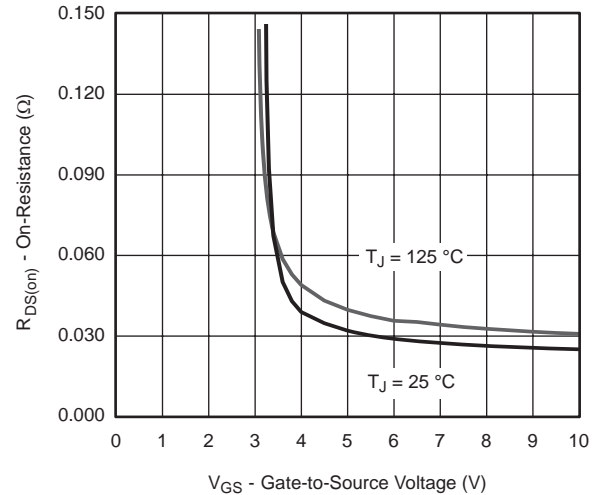


**On-Resistance vs. Junction Temperature**

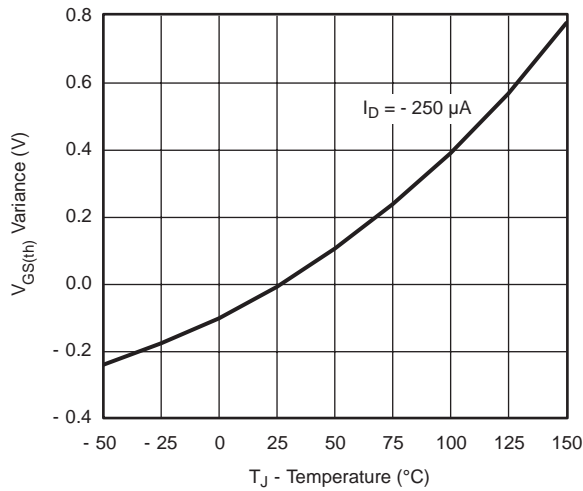
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



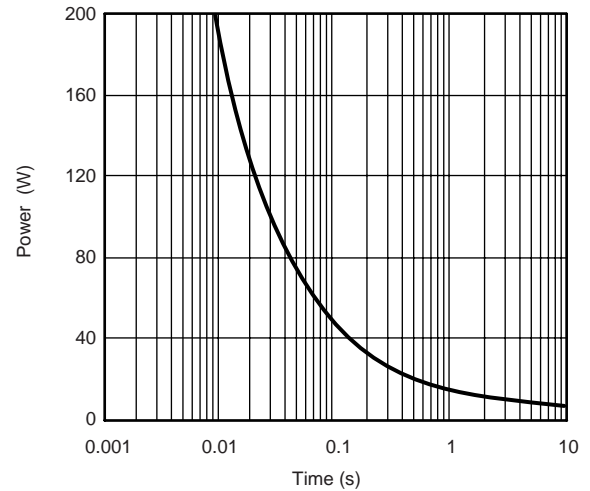
Source-Drain Diode Forward Voltage



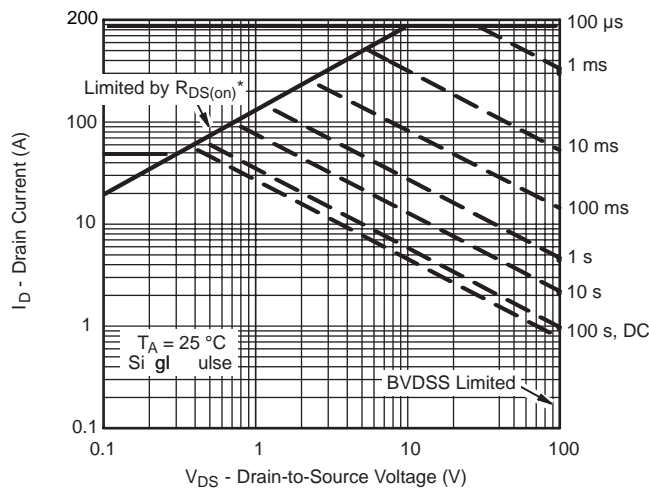
On-Resistance vs. Gate-to-Source Voltage



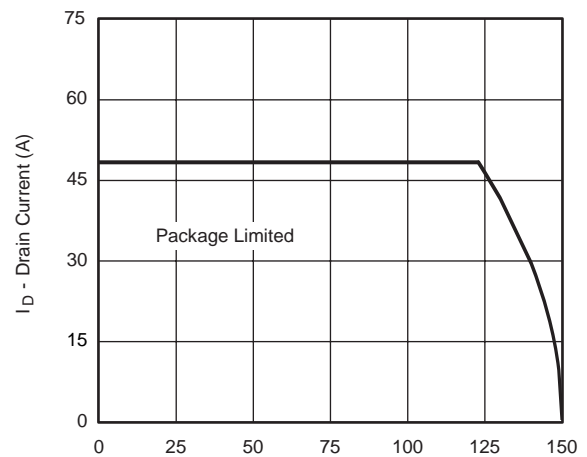
Threshold Voltage



Single Pulse Power, Junction-to-Ambient

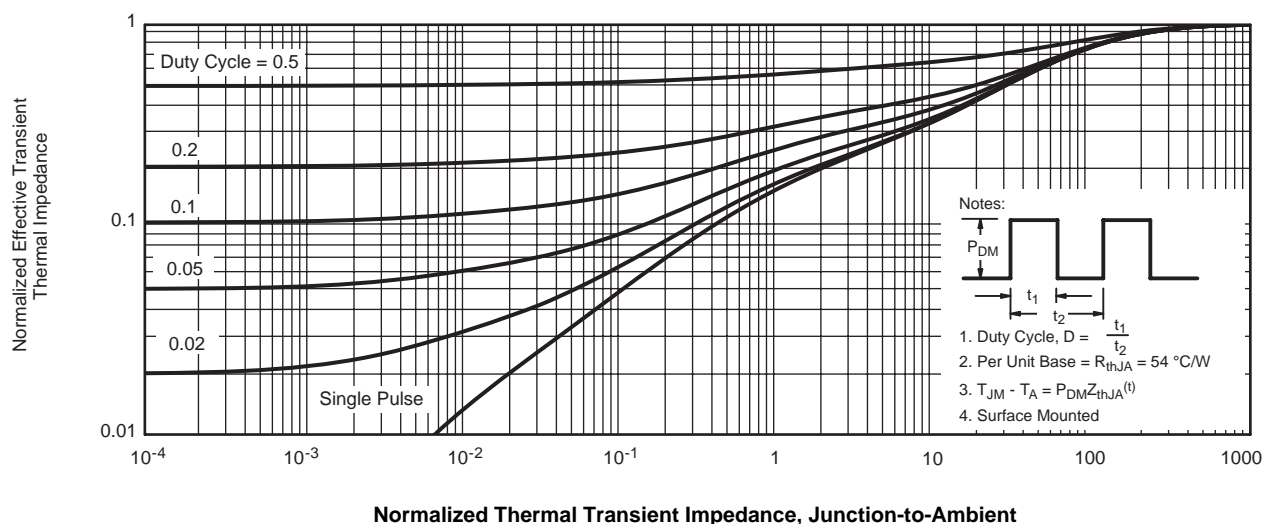


Safe Operating Area, Junction-to-Ambient



Current Derating\*

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150\text{ }^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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